

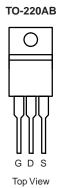
K3644-01-VB Datasheet N-Channel 100-V (D-S) MOSFET

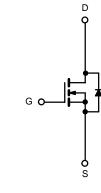
PRODUCT SUMMARY	
V _{DS} (V)	100
$R_{DS(on)} (\Omega)$ at $V_{GS} = 10 V$	0. 036
I _D (A) ^a	55
Configuration	Single

FEATURES

- Trench Power MOSFETS
- 175 °C Junction Temperature
- Low Thermal Resistance Package







N-Channel MOSFET

ABSOLUTE MAXIMUM RATING	S T _C = 25 °C, unless othe	erwise noted			
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	100	V	
Gate-Source Voltage		V _{GS}	± 20	v	
Continuous Drain Current (T ₁ = 175 °C)	T _C = 25 °C	1-	55		
Continuous Drain Current (1) = 175 C)	T _C = 125 °C	I _D	40	٨	
Pulsed Drain Current	·	I _{DM}	135	A	
Avalanche Current		I _{AR}	35		
Repetitive Avalanche Energy ^a	L = 0.1 mH	E _{AR}	61	mJ	
	T _C = 25 °C	P	127 ^b	14/	
Maximum Power Dissipation ^a	T _A = 25 °C ^c	– P _D –	3.75	W	
Operating Junction and Storage Temperature R	ange	T _J , T _{stg}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS	5			
Parameter		Symbol	Limit	Unit
Junction-to-Ambient	(PCB Mount) ^c	R _{thJA}	40	°C/W
Junction-to-Case (Drain)		R _{thJC}	1.4	5

Notes:

a. Duty cycle \leq 1 %.

b. See SOA curve for voltage derating.

c. When Mounted on 1" square PCB (FR-4 material).

* Pb containing terminations are not RoHS compliant, exemptions may apply.

Parameter	C, unless of Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	Symbol	Test conditions	IVIII.	тур.	IVIAX.	Unit
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{SS} = 0 V, I _D = 250 μA	100			
Gate-Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1		3	V
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, \text{ V}_{GS} = \pm 20 \text{ V}$	I		± 100	nA
Gale-Douy Leakage	'GSS	$V_{\rm DS} = 100 \ W_{\rm GS} = 0 \ V$			± 100	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125 \text{ °C}$		50	μA	
Zero Cale Vollage Drain Carrent	.022	$V_{DS} = 80 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 175 \text{ °C}$			250	μΑ
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	75		200	А
	'D(on)	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 5 \text{ A}$	10	0.036		
		$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 3 \text{ A}$		0.038		
Drain-Source On-State Resistance ^a	r _{DS(on)}	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 5 \text{ A}, \text{ T}_{J} = 125 \text{ °C}$		0.050		Ω
		$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 3 \text{ A}, \text{ T}_{J} = 175 \text{ °C}$		0.050		
Forward Transconductorsa	<i>a</i> .	$V_{\rm DS} = 15 \text{ V}, \text{ I}_{\rm D} = 15 \text{ A}$	10	0.005		S
Forward Transconductance ^a	9 _{fs}	VDS = 13 V, 10 = 13 A	10			3
Dynamic ^b	6			4500		
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1 MHz		4500		- 5
Output Capacitance	C _{oss}	$v_{GS} = 0$ v, $v_{DS} = 23$ v, $i = 1$ winz		270		pF
Reverse Transfer Capacitance	C _{rss}			90	00	
Total Gate Charge ^c	Q _g	y = 50 y y = 10 y = -40 0		35	60	nC
Gate-Source Charge ^c	Q _{gs}	$V_{DS} = 50$ V, $V_{GS} = 10$ V, $I_{D} = 40$ A		11		
Gate-Drain Charge ^c	Q _{gd}			9		
Gate Resistance	R _G			1.7		Ω
Turn-On Delay Time ^c	t _{d(on)}			11	20	
Rise Time ^c	t _r	$V_{DD} = 50 \text{ V}, \text{ R}_{L} = 1.25 \Omega$		12	20	- ns
Turn-Off Delay Time ^c	t _{d(off)}	${\rm I}_{\rm D}{\cong}40$ A, ${\rm V}_{\rm GEN}$ = 10 V, ${\rm R}_{\rm G}$ = 2.5 Ω		30	45	
Fall Time ^c	t _f			12	20	
Source-Drain Diode Ratings and Cha		$C = 25 \ ^{\circ}C^{\text{b}}$	-			
Continuous Current	l _S				40	А
Pulsed Current	I _{SM}				120	
Forward Voltage ^a	V _{SD}	I _F = 30 A, V _{GS} = 0 V		1.0	1.5	V
Reverse Recovery Time	t _{rr}			60	100	ns
Peak Reverse Recovery Current	I _{RM(REC)}	I _F = 30 A, di/dt = 100 A/µs		5	8	Α
Reverse Recovery Charge	Q _{rr}			0.15	0.4	μC

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %

b. Guaranteed by design, not subject to production testing.

c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

semi

www.VBsemi.com

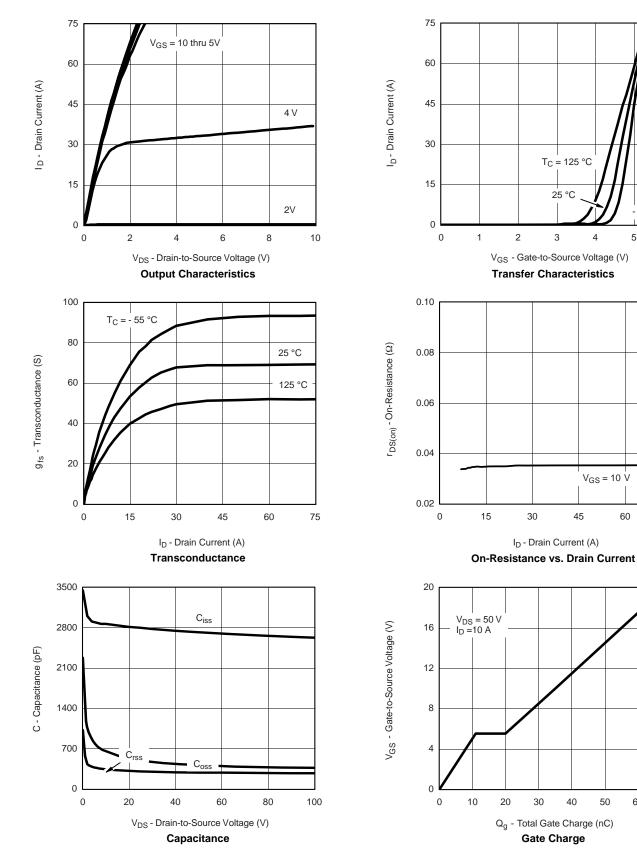


55 °C

6

75

5



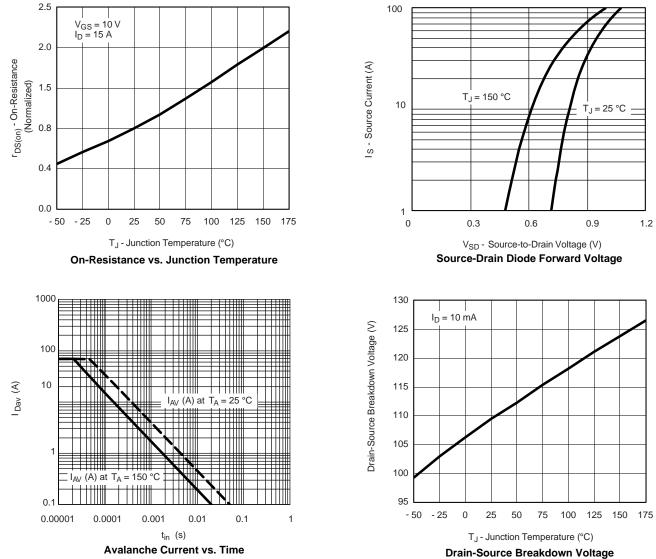
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

60

70



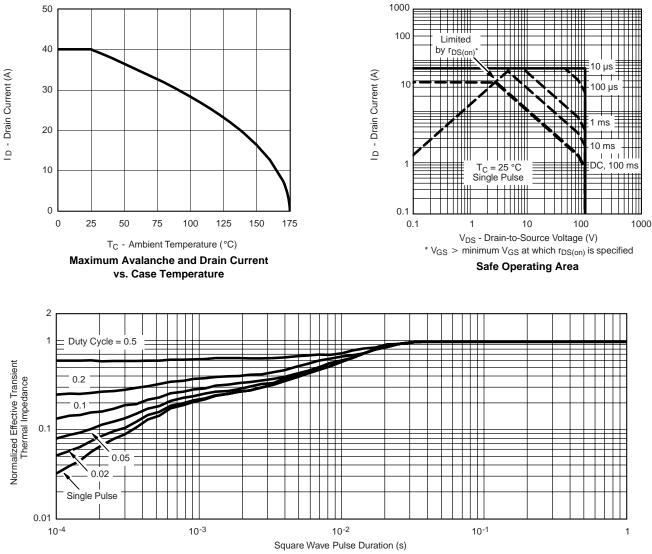
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



vs. Junction Temperature



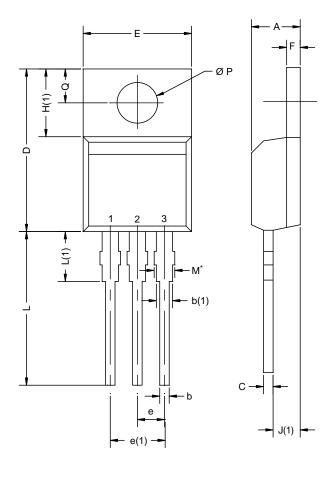
THERMAL RATINGS



Normalized Thermal Transient Impedance, Junction-to-Case



TO-220AB



N.	MAX. 4.65 1.01 1.73 0.61 15.49 10.51 2.67	MIN. 0.167 0.027 0.047 0.014 0.585 0.395 0.095	0.414
89 20 86 85 04 11	1.011.730.6115.4910.51	0.027 0.047 0.014 0.585 0.395	0.040 0.068 0.024 0.610 0.414
20 36 85 04 41	1.73 0.61 15.49 10.51	0.047 0.014 0.585 0.395	0.068 0.024 0.610 0.414
36 85 04	0.61 15.49 10.51	0.014 0.585 0.395	0.024 0.610 0.414
85 04 1	15.49 10.51	0.585	0.610
04	10.51	0.395	0.414
1			-
	2.67	0.095	
0			0.105
88	5.28	0.192	0.208
4	1.40	0.045	0.055
9	6.48	0.240	0.255
1	2.92	0.095	0.115
35	14.02	0.526	0.552
52	3.82	0.131	0.150
j4	3.94	0.139	0.155
60	3.00	0.102	0.118
5	32 54 50	54 3.94	543.940.139603.000.102

Notes

 * M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



Disclaimer

All products due to improve reliability, function or design or for other reasons, product specifications and data are subject to change without notice.

Taiwan VBsemi Electronics Co., Ltd., branches, agents, employees, and all persons acting on its or their representatives (collectively, the "Taiwan VBsemi"), assumes no responsibility for any errors, inaccuracies or incomplete data contained in the table or any other any disclosure of any information related to the product.(www.VBsemi.com)

Taiwan VBsemi makes no guarantee, representation or warranty on the product for any particular purpose of any goods or continuous production. To the maximum extent permitted by applicable law on Taiwan VBsemi relinquished: (1) any application and all liability arising out of or use of any products; (2) any and all liability, including but not limited to special, consequential damages or incidental; (3) any and all implied warranties, including a particular purpose, non-infringement and merchantability guarantee.

Statement on certain types of applications are based on knowledge of the product is often used in a typical application of the general product VBsemi Taiwan demand that the Taiwan VBsemi of. Statement on whether the product is suitable for a particular application is non-binding. It is the customer's responsibility to verify specific product features in the products described in the specification is appropriate for use in a particular application. Parameter data sheets and technical specifications can be provided may vary depending on the application and performance over time. All operating parameters, including typical parameters must be made by customer's technical experts validated for each customer application. Product specifications do not expand or modify Taiwan VBsemi purchasing terms and conditions, including but not limited to warranty herein.

Unless expressly stated in writing, Taiwan VBsemi products are not intended for use in medical, life saving, or life sustaining applications or any other application. Wherein VBsemi product failure could lead to personal injury or death, use or sale of products used in Taiwan VBsemi such applications using client did not express their own risk. Contact your authorized Taiwan VBsemi people who are related to product design applications and other terms and conditions in writing.

The information provided in this document and the company's products without a license, express or implied, by estoppel or otherwise, to any intellectual property rights granted to the VBsemi act or document. Product names and trademarks referred to herein are trademarks of their respective representatives will be all.

Material Category Policy

Taiwan VBsemi Electronics Co., Ltd., hereby certify that all of the products are determined to be oHS compliant and meets the definition of restrictions under Directive of the European Parliament 2011/65 / EU, 2011 Nian. 6. 8 Ri Yue restrict the use of certain hazardous substances in electrical and electronic equipment (EEE) - modification, unless otherwise specified as inconsistent.(www.VBsemi.com)

Please note that some documents may still refer to Taiwan VBsemi RoHS Directive 2002/95 / EC. We confirm that all products identified as consistent with the Directive 2002/95 / EC European Directive 2011/65 /.

Taiwan VBsemi Electronics Co., Ltd. hereby certify that all of its products comply identified as halogen-free halogen-free standards required by the JEDEC JS709A. Please note that some Taiwanese VBsemi documents still refer to the definition of IEC 61249-2-21, and we are sure that all products conform to confirm compliance with IEC 61249-2-21 standard level JS709A.